

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/521,312	TANAKA ET AL.	
	Examiner	Art Unit	
	Joseph P. Martinez	2873	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
see EAST text search attached: 359/10, 11, 30, 245, 259, 296, 307, 315, 316, 238; 365/125, 216; 345/694, 695, 698;382/210-211	7/26/2006	JPM
see EAST search attached: USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB	7/26/2006	JPM
reviewed PCT X-references	7/26/2006	JPM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner